

LM20080DLB6A

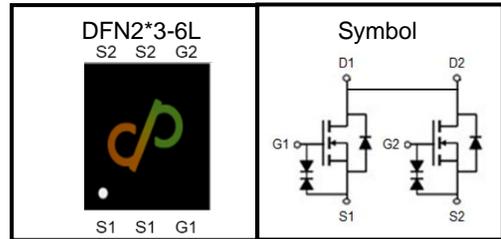


Dual N-Channel Enhancement Mode MOSFET Datasheet

Feature

- Reliable and Rugged
- ROHS Compliant & Halogen-Free
- Lower Q_g and Q_{gd} for high-speed switching
- Lower $R_{DS(ON)}$ to Minimize Conduction Losses

Pin Description



Applications

- Power Management in Notebook Computer, Portable Equipment and Battery Powered systems.

V_{DSS}	20	V
$R_{DS(ON)-Max}$	8	m Ω
I_D	7.8	A

Absolute Maximum Ratings (T_J=25°C Unless Otherwise Noted)

Symbol	Parameter	Rating	Unit
V_{DSS}	Drain-Source Voltage	20	V
V_{GSS}	Gate-Source Voltage	± 8	
T_J	Maximum Junction Temperature	150	°C
T_{STG}	Storage Temperature Range	-55 to 150	°C
$I_{DM}^{①}$	Pulse Drain Current Tested	$T_A=25^\circ C$ 19.5	A
$I_D^{②}$	Continuous Drain Current	$T_A=25^\circ C$ 7.8	A
		$T_A=70^\circ C$ 6.3	
$P_D^{②}$	Maximum Power Dissipation	$T_A=25^\circ C$ 0.98	W
		$T_A=70^\circ C$ 0.63	

Thermal Characteristics

Symbol	Parameter	Rating	Unit
$R_{\theta JA}^{②}$	Thermal Resistance-Junction to Ambient	Steady State 127	°C/W

Note ① : Max. current is limited by junction temperature.

Note ② : Surface Mounted on 1in² FR-4 board with 1oz

Electrical Characteristics (T_J=25°C Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Electrical Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	20	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =16V, V _{GS} =0V	-	-	1	uA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	0.35	0.6	0.85	V
I _{GSS}	Gate Leakage Current	V _{GS} =±8V, V _{DS} =0V	-	-	±10	uA
R _{DS(ON)} ^③	Drain-Source On-state Resistance	V _{GS} =4.5V, I _D =5.5A	-	6	8	mΩ
		V _{GS} =4V, I _D =5.5A	-	6	8.5	
		V _{GS} =3.7V, I _D =5.5A	-	6.2	9	
		V _{GS} =3.1V, I _D =5.5A	-	6.7	9.4	
		V _{GS} =2.5V, I _D =5.5A	-	7.8	11	
gfs	Forward Transconductance	V _{DS} =5V, I _D =5.5A	-	19	-	S
Dynamic Characteristics^④						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =10V, Freq.=1MHz	-	1340	-	pF
C _{oss}	Output Capacitance		-	180	-	
C _{rss}	Reverse Transfer Capacitance		-	150	-	
t _{d(ON)}	Turn-on Delay Time	V _{DD} =16V, I _D =5.5A, V _{GS} =4.5V, R _{GEN} =6Ω	-	26	-	nS
t _r	Turn-on Rise Time		-	60	-	
t _{d(OFF)}	Turn-off Delay Time		-	58	-	
t _f	Turn-off Fall Time		-	50	-	
Q _g	Total Gate Charge	V _{DS} =10V, V _{GS} =2.5V, I _D =11A	-	6	-	nC
Q _g	Total Gate Charge	V _{DS} =10V, V _{GS} =4.5V, I _D =11A	-	14	-	
Q _{gs}	Gate-Source Charge		-	2.8	-	
Q _{gd}	Gate-Drain Charge		-	3.3	-	
Source-Drain Characteristics						
V _{SD} ^③	Diode Forward Voltage	I _S =5.5A, V _{GS} =0V	-	0.75	1.1	V

Note ③ : Pulse test (pulse width≤300us, duty cycle≤2%).

Note ④ : Guaranteed by design, not subject to production testing.

N-Channel Typical Characteristics

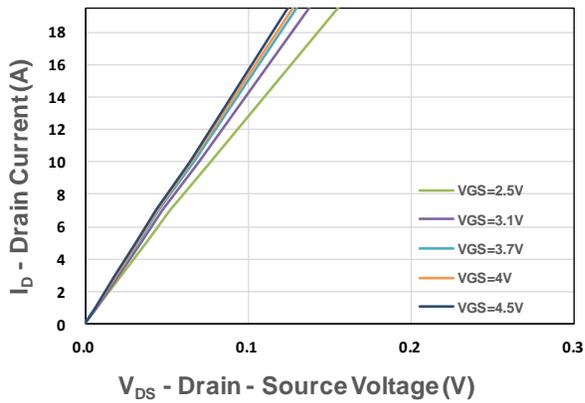


Figure 1. Output Characteristics

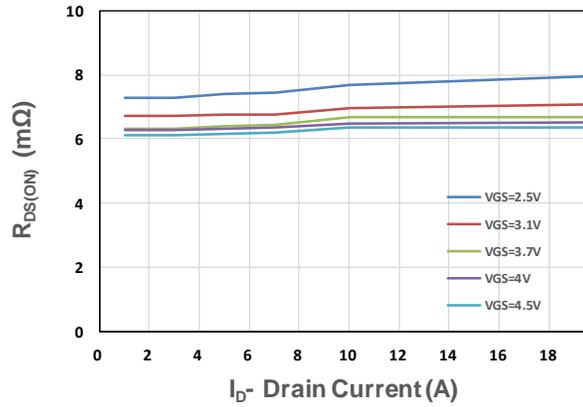


Figure 2. On-Resistance vs. I_D

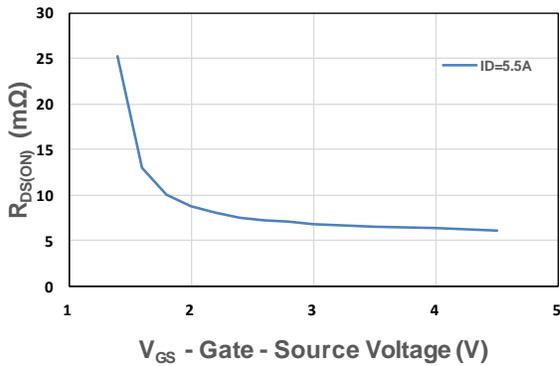


Figure 3. On-Resistance vs. V_{GS}

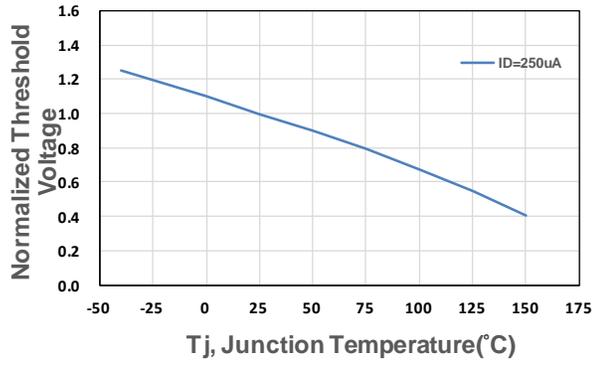


Figure 4. Gate Threshold Voltage

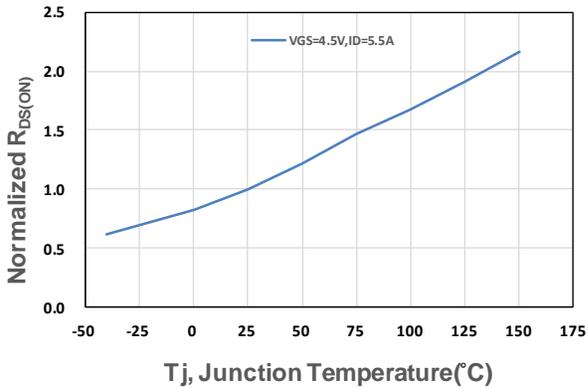


Figure 5. Drain-Source On Resistance

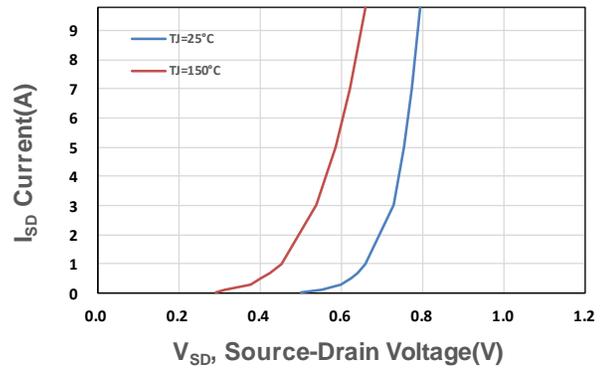


Figure 6. Source-Drain Diode Forward

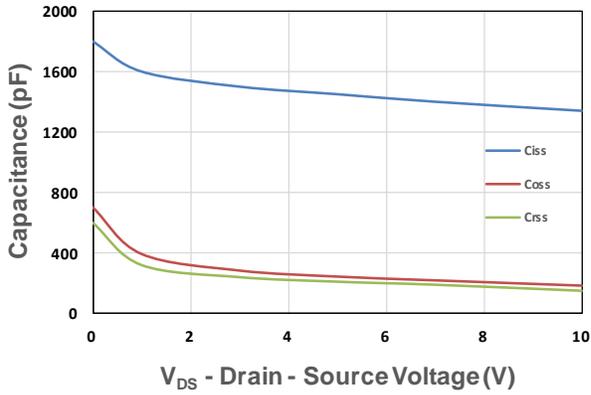


Figure 7. Capacitance

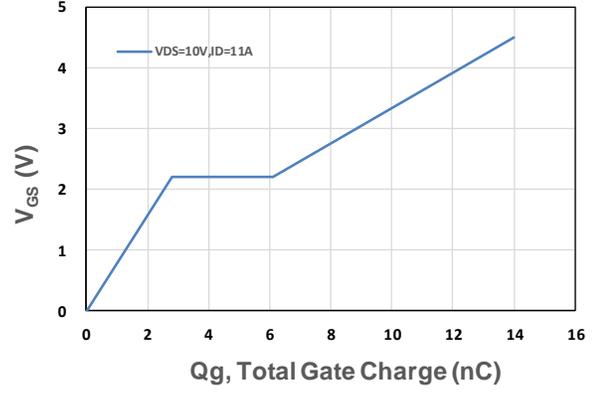


Figure 8. Gate Charge Characteristics

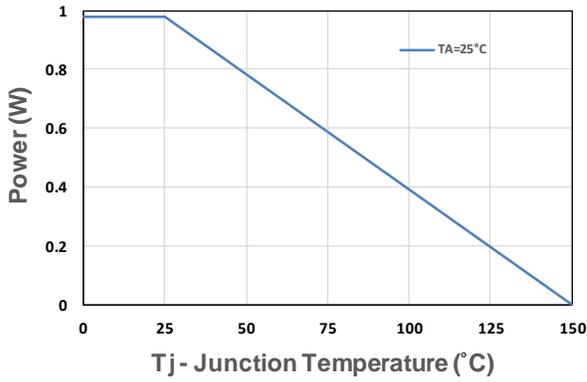


Figure 9. Power Dissipation

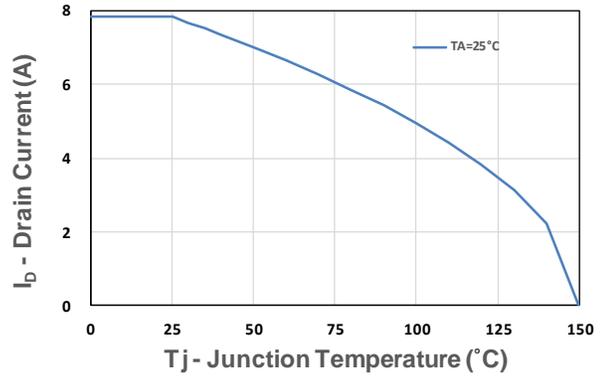


Figure 10. Drain Current

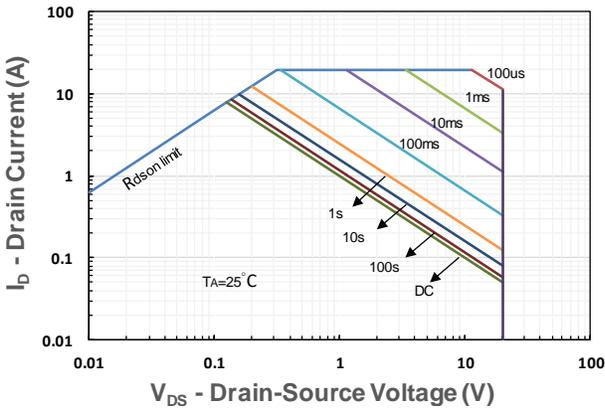


Figure 11. Safe Operating Area

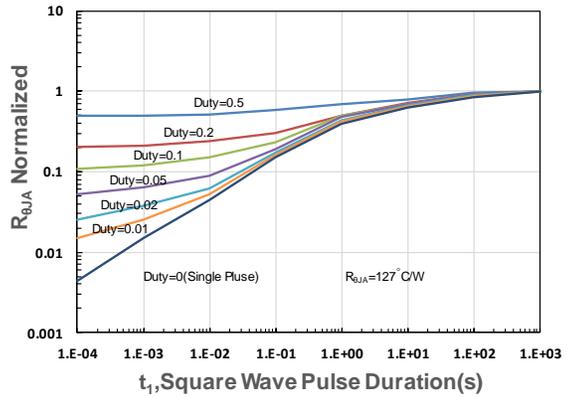


Figure 12. $R_{\theta JA}$ Transient Thermal Impedance

